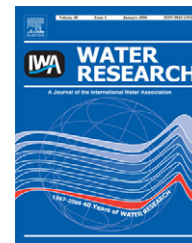


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# Size effect in reactivity of copper nanoparticles to carbon tetrachloride degradation

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## ABSTRACT

Surface area-normalized rate constants ( $k_{SA}$ ) of reaction between metallic nanoparticles and reducible contaminants, such as chlorinated hydrocarbons, heavy metals, and nitrate, have been reported to be dramatically increased as compared to that of commercial metallic powder. However,  $k_{SA}$  for individual pollutants in previously published data vary by as much as 1–2 orders of magnitude and much of this variability is due to the effect of various sizes. The size dependence of the reactivity of nanoparticles is not yet fully understood; however, yielding nanoparticles with uniform size and without agglomeration during the period of reaction would demonstrate the effect of varying particle size. In this study, resin-supported zerovalent copper with average particle size of 7, 10, 18, 26, and 29, respectively, were successfully synthesized and evidenced no agglomeration during the reaction period of 10 h. The  $k_{SA}$  of copper nanoparticles ( $k_{n,SA}$ ) was 110–120 times higher than that of powdered copper particles ( $k_{p,SA}$ ) when the copper particle size was about 10 nm. However, for diameters of 18–29 nm, the ratio of  $k_{n,SA}/k_{p,SA}$  was around 10–20, indicating that the reactivity of small copper nanoparticles (~10 nm) varies discontinuously. Thus, most variability in previous  $k_{SA}$  is attributed to the presence of small nanoparticles.

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## 1. Introduction

Extensive researches over the past 15 years have demonstrated that chemical reduction of many substances in the environment can be coupled with oxidation of zerovalent metals ( $M^0$ ) (Gillham and O'Hannesin, 1994; Matheson and Tratnyek, 1994; Orth and Gillham, 1996; Agrawal and Tratnyek, 1996). In the reductive dechlorination reaction by  $M^0$ , for example, the anodic  $M^0$  is oxidized into  $M^{n+}$  ions ( $n$  is valence), and chlorinated hydrocarbons, denoted as RCl, as electron acceptors are converted to hydrocarbons and chlorides under anaerobic conditions. The chemistry of the  $M^0$ /RCl/ $H_2O$  system is similar to that of the corrosion of  $M^0$  by RCl substituting oxygen as the oxidant. In this process, RCl

are mostly transformed into benign compounds such as hydrocarbons (RH) and chlorides ( $Cl^-$ ).

A surface-area-normalized kinetic model is most commonly used for heterogeneous reactions between reducible contaminants and metallic particles. This model assumes that the degradation rate of a contaminant is first order with respect to both total metallic surface and contaminant concentration, expressed as follows:

$$-d[C_w]/dt = k_{SA} a_s \rho_m [C_w] = k_{SA} \rho_a [C_w] = k_{obs} [C_w], \quad (1)$$

where  $k_{SA}$  ( $L h^{-1} m^{-2}$ ) is a surface area-normalized rate constant,  $a_s$  ( $m^2 g^{-1}$ ) is the specific surface area of metal,  $\rho_m$  ( $g L^{-1}$ ) is the metal mass loading in the reactor,  $\rho_a$  ( $m^2 L^{-1}$  of solution) is the surface area concentration of metal,  $k_{obs}$  is the

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observed rate constant, and  $C_w$  is the concentration of a contaminant. The amount of available surface area is the most important factor that governs the reduction rate. Studies have demonstrated the linear relationship between  $k_{\text{obs}}$  and  $\rho_m$  for carbon tetrachloride (Matheson and Tratnyek, 1994), 1,2-dibromo-3-chloropropane (Siantar et al., 1996), nitrobenzene (Agrawal and Tratnyek, 1996) and trichloroethene (Su and Puls, 1999). Additionally, reducing the diameter of the iron particles to vary the  $a_s$  values also proportionally accelerates the apparent rate of dechlorination reaction (Siantar et al., 1996).

Dimensions of metallic particles in the range 1–100 nm possess the advantages of larger specific surface area and higher surface reactivity over microscale powder to increase the chemical reduction rate of reducible contaminants. For example, the reduction rates for chlorinated methanes (Lien and Zhang, 1999; Feng and Lim, 2005), chlorinated ethenes (Wang and Zhang, 1997; Li et al., 2003), chlorinated benzenes (Lowry and Johnson, 2004), arsenic (Kanel et al., 2005), and nitrate (Liou et al., 2006) by iron nanoparticles on a mass basis were more than 2 orders of magnitude higher than those of commercial iron powder. Nanoparticles can be anchored onto a solid matrix for treatment of water, wastewater, and gaseous steams (Meyer et al., 2004). Additionally, direct subsurface injection of iron nanoparticles to effectively degrade chlorinated organic compounds has been demonstrated (Cantrell et al., 1997). The technology provides enormous flexibility for in situ or ex situ remediation. Values of  $k_{\text{SA}}$  are most often used to compare reactivity of nanoparticles to that of microscale powder, and are also critical parameters for the design of full-scale remediation operations. With the abundance of kinetic data now available for many compounds,  $k_{\text{SA}}$  varying by 1–2 orders of magnitude for individual compounds can be observed. The  $k_{\text{SA}}$  value for trichloroethene ( $\text{C}_2\text{HCl}_3$ ) reduced by iron nanoparticles as reported by Wang and Zhang (1997) is  $3 \times 10^{-3} \text{Lh}^{-1} \text{m}^{-2}$ , nearly similar to the results of Liu et al. (2005) ( $k_{\text{SA}} = 2 \times 10^{-3} \text{Lh}^{-1} \text{m}^{-2}$ ), though not as high as that reported by He and Zhao ( $k_{\text{SA}} = 2 \times 10^{-2} \text{Lh}^{-1} \text{m}^{-2}$ ). Moreover, the differences in  $k_{\text{SA}}$  between the results of Lien and Zhang (1999) and Feng and Lim (2005) for carbon tetrachloride ( $\text{CCl}_4$ ) and chloroform ( $\text{CHCl}_3$ ) vary by 1 and 2 orders of magnitude, respectively. In this case, the utility of  $k_{\text{SA}}$  values in the design of a treatment system would be questionable.

Iron nanoparticles were typically prepared by borohydride reduction of an aqueous iron salt (Wang and Zhang, 1997; Choe et al., 2001; Ponder et al., 2000; Schrick et al., 2002; Liao et al., 2003). However, due to the extremely high reactivity, the initially formed nanoparticles tended to be either oxidized quickly by surrounding media or to agglomerate during the reaction period, resulting in a rapid change in the number of reactive surface sites. Unfortunately,  $a_s$  determined by  $\text{N}_2$  isothermal adsorption (the BET surface area) presents the total surface area including both exposed surface of redox-active metal and redox-inactive metal oxide. This may not provide a true representation of the actual number of sites on the iron surface.

A more extreme source of variability in  $k_{\text{SA}}$  results from the effect of various sizes. Iron nanoparticles prepared by a solution method with  $\text{NaBH}_4$  as a reductant have sizes

between 1 and 100 nm with an average diameter of  $57 \pm 16$  nm (Cao et al., 2005). Applying a stabilizer to modify the solution method has been developed for the formation of much smaller nanoparticles. Li et al. (2003) used cetyltrimethylammonium bromide as a stabilizer in the water-in-oil microemulsion system to obtain the average particle size of about 10 nm. The results of their research indicated that the initial dechlorination rate for microemulsion nanoparticles was 2.6 times higher than that for the solution nanoparticles. He and Zhao (2005) applied a water-soluble starch as a stabilizer to prepare starched-iron nanoparticles. The mean particle size was  $14 \pm 12$  nm with much of the particles less than 10 nm. The starched nanoparticles exhibited values of  $k_{\text{SA}}$  10 times higher than those of the solution nanoparticles when used for dechlorination of  $\text{C}_2\text{HCl}_3$ . Additionally, our previous study (Liou et al., 2006), differing iron precursor concentrations to obtain various nanoparticle size distribution, indicated that the reactivity of iron nanoparticles with diameters of 9–10 nm for the denitrification of aqueous nitrate was higher than that of iron nanoparticles with diameters of 20–60 nm and of 20–70 nm. The most likely cause for the high chemical reactivity of small iron nanoparticles is the rise in adsorbed atomic hydrogen ( $\text{H}_{\text{ads}}$ ) production on its surface. The peculiarity of these nanoparticles is due to their intrinsic heterogeneities: presence of different facets and presence of low coordinated edge sites (Henry, 2000). Thus, particle size is an important factor in controlling its reactivity.

In this study, the use of a support medium to stabilize and isolate a metal particle to clarify relations between size of copper nanoparticles and the reactivity to  $\text{CCl}_4$  dechlorination avoids the effect of agglomeration. The use of copper as a reductant was preferred due to the following: (1) The reliable in situ measurement of the surface area of resin-supported copper particles by temperature-programmed reduction (TPR) has been demonstrated (Grift et al., 1991), and (2) nanoscale zero valent copper exhibits relative stability in water, avoiding reaction with surrounding media. Nanoparticles with uniform size, and absence of agglomeration during the period of reaction would demonstrate the effect of varying particle size on its reactivity to the dechlorination of  $\text{CCl}_4$ .

## 2. Experimental section

### 2.1. Chemicals

All aqueous solutions were made in water purified with a Milli-Q system ( $18.2 \text{M}\Omega \text{cm}^{-1}$ ). High-pressure liquid chromatography grade carbon tetrachloride was obtained from Aldrich (USA). Copper (II) nitrate trihydrate was from Alfa (USA). Copper powder was obtained from Riedel-de Haen (approx. 0.04 mm, >99.5%, GR grade, USA).

### 2.2. Preparation of copper nanoparticles coated resin

Firstly, the resin was exchanged with desired concentration of  $\text{Cu}^{2+}$  from an aqueous solution of  $\text{Cu}(\text{NO}_3)_2 \cdot 3\text{H}_2\text{O}$ , followed by thorough washing to remove excess physisorbed copper ions. After washing, the fresh samples were dried in air at  $120^\circ \text{C}$  for

12 h. The dried samples were reduced from ambient to 300 °C at 10 °C min<sup>-1</sup> in a flow of H<sub>2</sub>/N<sub>2</sub> (20 vol%, 100 mL min<sup>-1</sup>) and keeping it at 300 °C for 3 h, then cooled down to room temperature in the reducing gas atmosphere. According to the above description, five samples were prepared at various copper loading including 5, 10, 20, 30, 50 mg-Cu g-resin<sup>-1</sup>.

### 2.3. Characterization of copper nanoparticles coated resin

The oxidation states of copper on the resin were identified by electron spectroscopy for chemical analysis (ESCA). The ESCA measurements were performed by using a Vacuum Generators ECSALAB MKII photoelectron spectrometer (East Grinstead, UK) with an Al K<sub>α</sub> X-ray source (1486.6 eV) and a hemispherical 150 mm mean radius electron analyzer with a take-off angle of 90°. During the data acquisition, the pressure in the sample chamber did not exceed 9.0 × 10<sup>-9</sup> Pa. Hitachi H-7100 transmission electron microscopy (TEM) was used to characterize the size distribution of the metal particles.

### 2.4. Surface area and average particle size of attached copper particles

Two experiments were performed by TPR studies with the apparatus similar to that described previously (Bond and Namijo, 1989). TPR apparatus of standard design was allowed flows of (1) pure helium gas, (2) 10 vol% H<sub>2</sub> in Ar, (3) pure N<sub>2</sub>O to be passed sequentially through the reactor and the thermal conductivity detector (TCD). Before these experiments, the fresh sample of Cu<sup>2+</sup> on the resin was dried in air at 120 °C for 18 h. Then, it was heated in a flow of helium (50 mL min<sup>-1</sup>) from room temperature to 250 °C at 10 °C min<sup>-1</sup>. Dwelling for 30 min at 250 °C to remove the volatiles and then cooled down to room temperature. In the first TPR, a flow of H<sub>2</sub>/Ar (10 vol%, Hoehloos) was used as reducing gas. The oven temperature was programmed from ambient to 350 °C at 10 °C min<sup>-1</sup> and held for 60 min. Subsequently, the second TPR was to estimate the specific surface area and the particle size of Cu<sup>0</sup> on the resin. In that, pure N<sub>2</sub>O (99.998 vol%, Matheson) was used as oxidizing gas, helium gas (99.99 vol%, Hoekloos) as flushing gas and H<sub>2</sub>/Ar (10 vol%, Hoehloos) as reducing gas. After the first TPR experiment, these gases were passed sequentially through the oven and detector. A sample of Cu<sup>2+</sup> on the resin was reduced by the first TPR experiment, and then cooled down to room temperature. The flow of H<sub>2</sub>/Ar was then replaced by helium gas (60 mL min<sup>-1</sup>) to purge the reduced sample for 10 min. Exposing the reduced sample to a flow of pure N<sub>2</sub>O (60 mL min<sup>-1</sup>) at 100 °C for 120 s, and then cooled down to room temperature in a flow of helium gas (60 mL min<sup>-1</sup>). Finally, a flow of H<sub>2</sub>/Ar (10 vol%, 60 mL min<sup>-1</sup>) was introduced to reduce CuO<sub>2</sub> on the Cu<sup>0</sup> surface, named the second TPR.

### 2.5. Reactor system

The degradation and sorption of CCl<sub>4</sub> by Cu<sup>0</sup>/resin were measured in the closed batch system with zero headspace. In these systems, 0.2 g Cu<sup>0</sup>/resin and 14.8(±0.05) mL Ar-purged unbuffered Milli-Q water were added into 15 mL amber serum vials (Supelco). A 100 μL aliquot of CCl<sub>4</sub> (700 mg L<sup>-1</sup>)

was then added under the water level. Immediately after CCl<sub>4</sub> addition, the vials were capped with Teflon silicone septa and aluminum seals and then mixed on a rotary shaker (50 rpm) at room temperature (23 ± 1 °C) in the dark.

### 2.6. Sample analysis

Each vial was analyzed by liquid–liquid and liquid–solid extraction using *n*-hexane as a solvent to determine aqueous phase and total CCl<sub>4</sub> concentration according to the sampling method described in our previous study (Lin et al., 2005). The CCl<sub>4</sub> concentrations were measured using a HP5890 GC equipped with a DB-624 capillary column and an electron capture detector operated in the splitless mode. The total CCl<sub>4</sub> mass (mg vial<sup>-1</sup>) come from the sum of both the measured masses in the liquid–liquid and the liquid–solid extractions. Control total (mass per vial) concentrations were stable over the reaction period. The extraction recoveries for CCl<sub>4</sub> from aqueous and sorbed phases in the blank resin vials (0.2 g-resin vial<sup>-1</sup>) were ranged from 91% to 103%, that reasonable assumed this method can extract total CCl<sub>4</sub> mass in vial. All experiments were duplicated or triplicated.

## 3. Results and discussion

### 3.1. Characterization of copper nanoparticles coated resin

The oxidation states of the resulting copper on the resin (5 mg-Cu g-resin<sup>-1</sup>) were characterized by ESCA. The XPS spectra of both the fresh prepared sample and the used one are presented in Fig. 1(a) and (b), respectively. These spectra consist of the Cu2p<sub>3/2</sub> main photoelectron peak (centered at 932.8–935.1 eV). The Cu2p<sub>3/2</sub> peaks at binding energy of 932.8 eV found in the XPS spectra of fresh prepared Cu/resin (Fig. 1(a)) indicated nearly all copper in Cu/resin is present as Cu<sup>0</sup>. This preparation process of Cu/resin was proven to be high enough to ensure nearly complete reduction to Cu<sup>0</sup>. After the dechlorination reaction of CCl<sub>4</sub> for 10 h, three Cu2p<sub>3/2</sub> peaks were found in the XPS spectra at binding energy of 932.8, 933.7 and 935.1 eV, corresponding to Cu<sup>0</sup>, CuO and CuCl<sub>2</sub> with 4, 10, 86% of total copper loading by mole (the deconvolution results are shown in Fig. 1(b)). Thus, the XPS spectra of Cu/resin indicates the relative abundance of Cu (II) species on its surface after dechlorination reaction.

The morphology and size of the resulting Cu<sup>0</sup> on the resin (10 mg-Cu g-resin<sup>-1</sup>) was viewed with TEM. Fig. 2(a) showed the copper particles were nearly spherical in shape and uniform in size with the average particle size about 10 nm. After the dechlorination reaction of CCl<sub>4</sub>, copper particles didn't significant aggregate and presented similar particle size distribution (Fig. 2(b)).

According to the set of experiments of Cu<sup>0</sup> surface oxidation in N<sub>2</sub>O flow at various temperatures by Evans et al. (1983), the surface area of Cu<sup>0</sup> particles determined by TPR was close to its BET surface area when the cross-sectional area of the active adsorptive atom was assumed to be 1.4 × 10<sup>19</sup> Cu-atoms m<sup>-2</sup>. As described by Grift et al. (1991), the determination of the surface area of attached copper particles (S<sub>Cu</sub>, m<sup>2</sup>-Cu g-resin<sup>-1</sup>) is based on the measurement

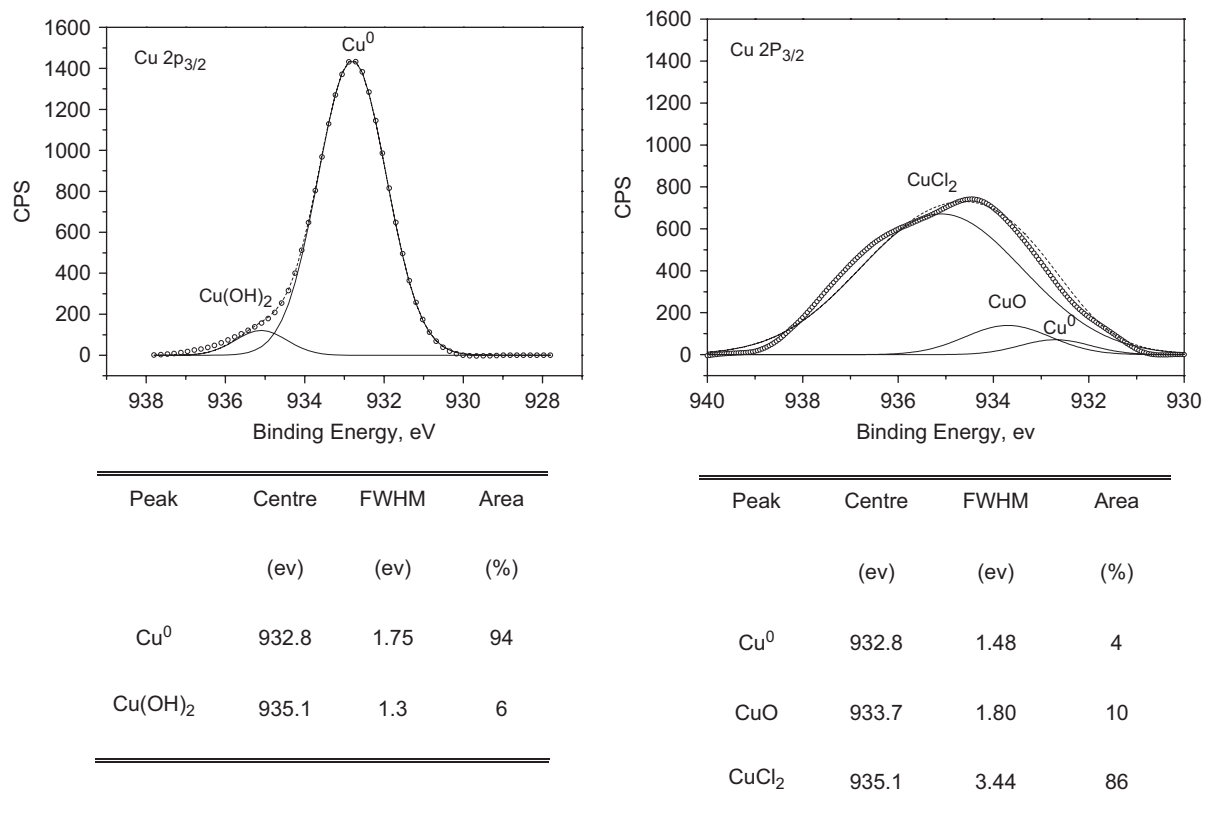


Fig. 1 – XPS spectra of Cu2p<sub>3/2</sub> for (a) before; (b) after the dechlorination reaction for 10 h.

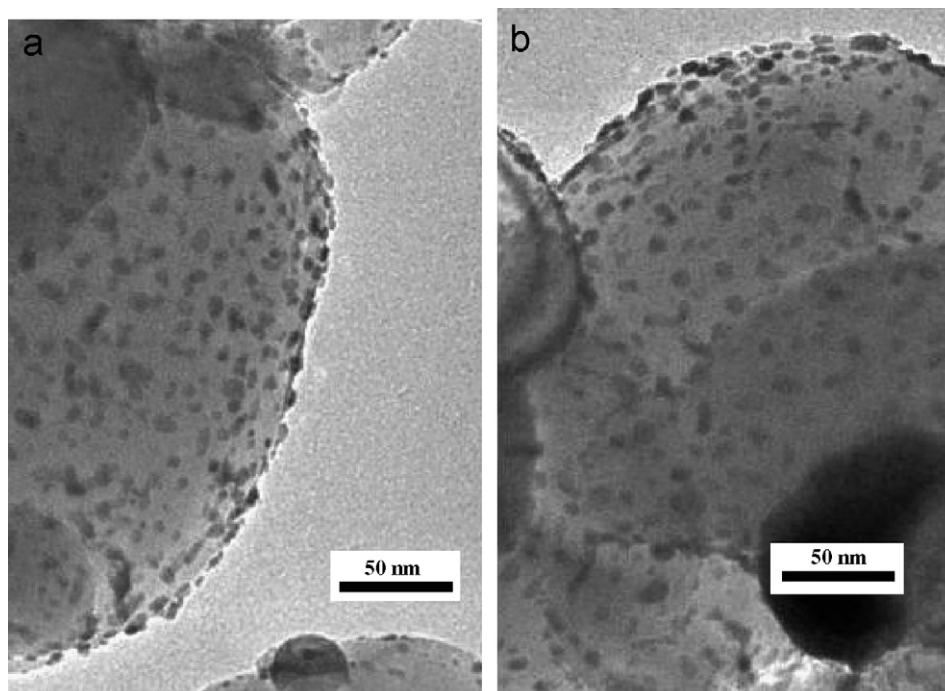


Fig. 2 – The TEM images of resin (10 mg-Cu g-resin<sup>-1</sup>) for (a) before; (b) after the dechlorination reaction for 10 h. The metallic particles appear as spots with high contrast.



of hydrogen consumption after surface oxidation of the copper by  $N_2O$ .

Step 1:



Step 2:



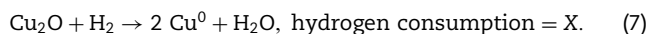
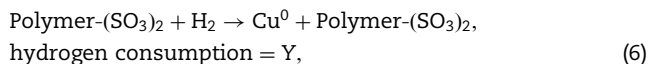
Compared to the area of the TCD signals of 1 mL  $H_2$  ( $40.9 \mu\text{mol}$  at 1 atm,  $25^\circ\text{C}$ ) passing through the reactor of TPR, the  $H_2$  consumption of various copper ions loading samples in the first and second TPR would be obtained; the numbers of total and surface copper atoms were calculated by multiplying a factor that expresses the stoichiometry of Eqs. (2) and (3). Copper surface area ( $S_{Cu}$ ) on the resin would be readily calculated with above related values.

$$N_{\text{surf Cu}} = (A_{\text{surf Cu}}/A_{1 \text{ mL } H_2})40.9 \times 10^{-6}N_s \text{ (mole).} \quad (4)$$

$$S_{Cu} = (N_{\text{surf,Cu}} \times N_{\text{av}})/(1.4 \times 10^{19}W_{\text{resin}}) \text{ (m}^2 \text{ - Cu g - sample}^{-1}), \quad (5)$$

where  $N_{\text{surf Cu}}$  is the number of surface copper atoms;  $A_{\text{surf Cu}}$  is the area of the TCD signal for the second TPR;  $A_{1 \text{ mL } H_2}$  is the area of the TCD signal for 1 mL  $H_2$ ;  $N_s (= 2)$  is the stoichiometry of Eq. (5);  $N_{\text{av}}$  is Avogadro constant ( $6.023 \times 10^{23} \text{ mole}^{-1}$ );  $W_{\text{resin}}$  is the mass (g) of the resin in the reactor of TPR.

The dispersion ( $D$ ) of copper was defined as the ratio of the number of copper surface atoms and total number of copper atoms (Eq. (8)). In other words,  $D$  is the fraction of the total of copper accessible to the reactant molecules. As Grift et al. (1991) described, the measurement of dispersion of Cu on the resin was based on the amount of the  $H_2$  consumption of the first and second TPR, named  $Y$  and  $X$ , respectively. The reactions corresponding to the first and second TPR, respectively, are Eqs. (6) and (7).



The dispersion of Cu on resin was calculated by

$$D = N_{\text{surf Cu}}/N_{\text{tot Cu}} = 2X/Y, D \leq 1, \quad (8)$$

where  $N_{\text{tot,Cu}}$  is total number of copper atoms. Assuming the copper particles in spherical shape, Boundart and Djega-Mariadassou (1984) proposed an approximate conversion between dispersion  $D$  and average particle size  $d_{AV}$  (nm).

$$d_{AV} = 0.9/\text{dispersion (nm)}. \quad (9)$$

Figs. 3(a) and (b) show the profiles of the first and second TPR, respectively. The values of  $X_i$  and  $Y_i$  ( $i = 5, 10, 20, 30, 50$ ) of these samples were normalized to the area of the TPR signal for 1 mL  $H_2$ . To establish the same base of the TPR profiles for various Cu loadings, samples of different weights were added to the reactor of TPR, 0.4 g for the 5 mg-Cu g-resin $^{-1}$ , 0.3 g for the 10 mg-Cu g-resin $^{-1}$ , and 0.2 g for the 20, 30 and 50 mg-Cu g-resin $^{-1}$ . Significant signals for initially consumed  $H_2$  were appeared at  $250\text{--}290^\circ\text{C}$  in the first TPR, but at  $150\text{--}180^\circ\text{C}$  in the second TPR. The difference of activated energy between sorbed Cu ions on the resin and  $Cu_2O$  reduced by  $H_2$  may account for this observation. Table 1 lists

the resulting values of  $S_{Cu}$ ,  $D$  and  $d_{AV}$  of Cu on the resin. As Cu loading on the resin increases, the  $S_{Cu}$  increased from 0.50 to  $0.68 \text{ Cu-m}^2 \text{ g-resin}^{-1}$  for Cu loading between 5 mg-Cu g-resin $^{-1}$  and 10 mg-Cu g-resin $^{-1}$ . However, it holds at the amount of approximate  $0.55 \text{ Cu-m}^2 \text{ g-resin}^{-1}$  for 20 mg-Cu g-resin $^{-1}$  up to 50 mg-Cu g-resin $^{-1}$ . Consequently, increasing the Cu loading on resin served initially to increase the number density rather than the size of particles on the resin. Then, a further increase led to agglomeration of Cu particles at the temperature of reduction, simultaneously indicated by an increase in the average particle size. The prepared resin-supported copper were characterized by ESCA, TEM, and TPR, indicating the values of exposed surface area of  $Cu^0$  on the resin without significant change during the period of reaction.

### 3.2. Dechlorination of $CCl_4$

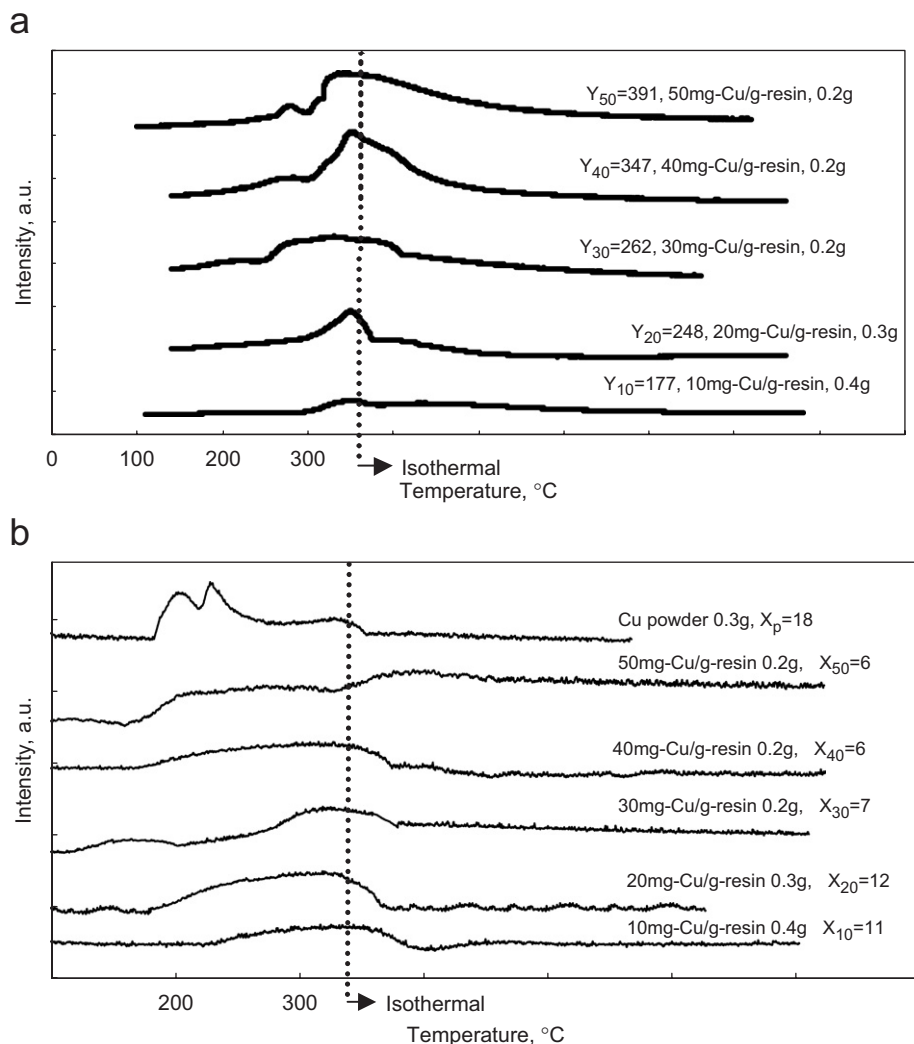
A conceptual model of the nanoscale zero valent copper-resin- $CCl_4$ -water system incorporating concurrent the degradation reaction by  $Cu^0$  and sorption/desorption by the resin is similar to that proposed by Burris et al. (1998). The disappearance of  $CCl_4$  from aqueous solutions may be due to degradation reactions by zero valent copper or sorption onto the resin.

$$-dC_w/dt = k_a C_w + \alpha_s C_s - \alpha_d C_s, \quad (10)$$

where  $C_w$  and  $C_s$  are the aqueous, and sorbed-phase  $CCl_4$  concentrations  $\mu\text{g}$  per vial;  $\alpha_s$  and  $\alpha_d$  are the sorption and desorption rate constants, respectively. The loss of total mass of  $CCl_4$  ( $C_T$ ) in a closed reactor was attributed to the degradation reaction by  $Cu^0$  and fitted with a first-order rate equation of the form

$$-dC_T/dt = k_{\text{obs}} C_w = k_{SA} a_s \rho_m C_w. \quad (11)$$

Eqs. (10) and (11) state the decline in the concentration of target contaminants in the batch system was caused only by reduction reaction at the  $Cu^0$  surface; however, the apparent concentration in the aqueous phase was reduced by the combination of sorption and reduction reaction. Regardless of the mechanism of sorption, Eq. (10) or (11) can be simplified as Eq. (1). Fig. 4(a) is the result of controlled experiment with 91–103% recovery of total  $CCl_4$  mass. Fig. 4(b)–(f) separately present experimental results (the residual aqueous and total  $CCl_4$  mass in the vial) for the reaction of 0.2 g of 5, 10, 20, 30, 50 mg-Cu g-resin $^{-1}$  with  $1.05 \text{ mg vial}^{-1}$  initial mass of  $CCl_4$ . Additionally, Fig. 4(g) presents the residual aqueous  $CCl_4$  mass in the vial containing 0.3 g powdered copper over the period of reaction. As presented in Fig. 4(b)–(f), both total and aqueous  $CCl_4$  mass declined substantially. The rate of loss of total  $CCl_4$  mass obtained using 5 mg-Cu g-resin $^{-1}$  resembled that of 10 mg-Cu g-resin $^{-1}$ , and both losses were significantly faster than those obtained using 20, 30, and 50 mg-Cu g-resin $^{-1}$ . The first-order observed rate constants ( $k_{\text{obs}}$ ) of the dechlorination of  $CCl_4$  in contact with Cu g-resin $^{-1}$  were obtained from the slope of a plot of total  $CCl_4$  loss rate ( $-dC_T/dt$ ) versus  $CCl_4$  concentration in the aqueous phase,  $C_w$  in  $\text{mg-}CCl_4 \text{ vial}^{-1}$ , using linear least-squares analysis. The  $k_{\text{obs}}$  values were  $1.644 \pm 0.174$ ,  $2.046 \pm 0.132$ ,  $0.342 \pm 0.042$ ,  $0.209 \pm 0.011$  and  $0.264 \pm 0.03 \text{ h}^{-1}$  for 5, 10, 20, 30, and 50 mg-Cu g-resin $^{-1}$ , respectively (shown in Table 1). The values of  $k_{SA}$  were



**Fig. 3 – Consumption of H<sub>2</sub> during temperature programmed reduction of nano-Cu<sup>0</sup>/resin: (a) after complete oxidation (the first TPR); (b) after surface oxidation (the second TPR).**

**Table 1 – The specific surface area, dispersion and average diameter of particles, and its reactivity to CCl<sub>4</sub>**

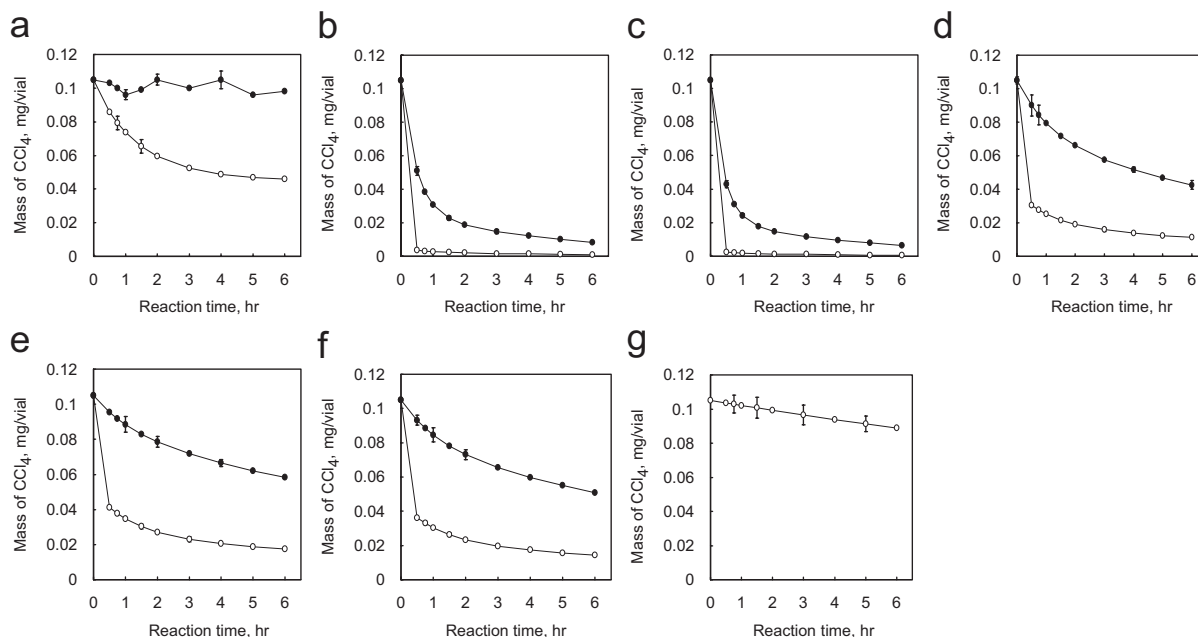
Sample (mg-Cu g-resin <sup>-1</sup> )	W <sub>sample</sub> (g)	H <sub>2</sub> consumption (mole g-resin <sup>-1</sup> )	S <sub>Cu</sub> <sup>a</sup> (m <sup>2</sup> -Cu g-resin <sup>-1</sup> )	Dispersion (D)	d <sub>AV</sub> (nm)	k <sub>obv</sub> <sup>b</sup> (h <sup>-1</sup> )	k <sub>SA</sub> × 10 <sup>-2b</sup> (L m <sup>-2</sup> h <sup>-1</sup> )	$\frac{k_{n,SA}}{k_{p,SA}}$
5	0.4	11.51	0.50	0.127	7	1.644 ± 0.174	24.90 ± 2.64	125
10	0.3	15.86	0.68	0.089	10	2.046 ± 0.132	22.49 ± 1.45	112
20	0.2	13.04	0.56	0.051	18	0.342 ± 0.042	4.57 ± 0.57	23
30	0.2	12.02	0.52	0.034	26	0.209 ± 0.011	3.03 ± 0.16	15
50	0.2	12.28	0.53	0.031	29	0.264 ± 0.03	3.75 ± 0.42	14
Powdered Cu	0.3	23.87	1.03	—	—	0.028 ± 0.002	0.20 ± 0.02	1

<sup>a</sup> The S<sub>Cu</sub> of these samples are given in square meter per gram resin, Cu-m<sup>2</sup> g-resin<sup>-1</sup>, but in square meter per gram Cu, Cu-m<sup>2</sup> g-Cu<sup>-1</sup>, for commercial powdered Cu.

<sup>b</sup> Average ± 95% confidence level.

obtained by normalizing  $k_{obs}$  according to the S<sub>Cu</sub> and the mass concentration of the sample (0.2 g Cu<sup>0</sup>/resin per 15 mL amber serum vial). As indicated in Table 1, the  $k_{SA}$  of nanoscale Cu particles (named  $k_{n,SA}$ ) was 110–120 times higher than that (named  $k_{p,SA}$ ) of commercial powdered Cu

particles when the Cu<sup>0</sup> particle size was about 10 nm. However, for diameters of 20–30 nm, the ratio of  $k_{n,SA}/k_{p,SA}$  was around 10–20. This indicates the size dependence of the reactivity of small copper nanoparticles varies discontinuously.



**Fig. 4** – The residual aqueous and total  $\text{CCl}_4$  mass with 95% confidence interval for (a) control with resin only, (b) 5 mg-Cu g-resin $^{-1}$ ; (c) 10 mg-Cu g-resin $^{-1}$ ; (d) 20 mg-Cu g-resin $^{-1}$ ; (e) 30 mg-Cu g-resin $^{-1}$ ; (f) 50 mg-Cu g-resin $^{-1}$ ; (g) Cu powder. (○) referred to the residual aqueous  $\text{CCl}_4$  mass; (●) referred to the residual total  $\text{CCl}_4$  mass.

#### 4. Conclusions

In this work, the size dependence of reactivity toward carbon tetrachloride was studied via synthesizing copper nanoparticles with uniform size dispersed on a cation resin. The  $k_{n,SA}$  was sharply increased by a factor of 110–120 when  $\text{Cu}^0$  particle size was close to 10 nm. However, for diameters of 20–30 nm, the ratio of  $k_{n,SA}/k_{p,SA}$  was around 10–20, indicating the reactivity of small Cu particles ( $\sim 10$  nm) varies discontinuously. Thus, most variability in previous  $k_{SA}$  is attributed to the presence of small nanoparticles.

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